

## Search Notes



**Application/Control No.**

10/696,776

**Examiner**

Raj K. Jain

**Applicant(s)/Patent under  
Reexamination**

HUIITEMA, CHRISTIAN

## **Art Unit**

2616

**SEARCHED**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference search		4/29/2007	RJ

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPGPUB, USPAT	4/25/2007	RJ
370/241.1,242,254,255,256 TEXT SEARCH.	4/25/2007	RJ
711/118-130 TEXT SEARCH	4/25/2007	RJ
Inventor search	4/29/2007	RJ
Updated search	4/29/2007	RJ